

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10733395	WASHIO ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	Sherman, Stephen G	2629

<b>SEARCHED</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
345	100	10/13/2006	SS
345	87,98-99,204	2/26/2007	SS

<b>SEARCH NOTES</b>			
<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>	
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Search Updated	4/21/2008	SS	
NPL Documents Searched (iEEE,INSPEC,ACM)	4/21/2008	SS	

<b>INTERFERENCE SEARCH</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
345	87,98-100,204	4/21/2008	SS
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